



N 沟道增强型场效应晶体管

N-CHANNEL MOSFET

FHP80N07E/FHS80N07E/FHD80N07E/FHF80N07E

主要参数 MAIN CHARACTERISTICS

ID	80A
VDSS	68V
Rdson-typ（@Vgs=10V）	7.1 mΩ
Qg-typ	40 nC

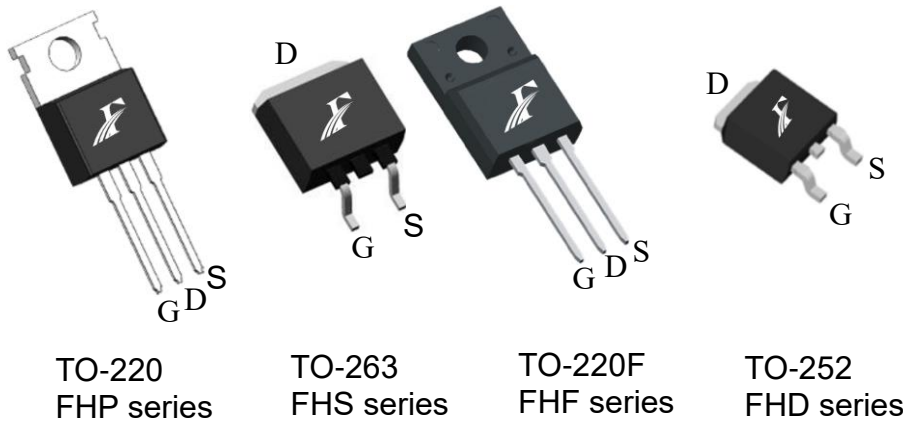
用途 APPLICATIONS

电池管理系统	BMS
电机控制和驱动	Motor control and drive
逆变电源	Power management for inverter systems

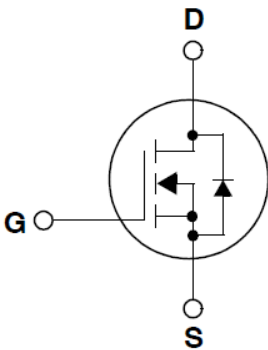
产品特性 FEATURES

低栅极电荷	Low gate charge
低 Crss (典型值 180 pF)	Low Crss (typical 180 pF)
开关速度快	Fast switching
100%经过雪崩测试	100% avalanche tested
100%经过热阻测试	100% DVDS tested
100%经过 Rg 测试	100% Rg tested
高抗 dv/dt 能力	Improved dv/dt capability
RoHS 产品	RoHS product

封装形式 Package



等效电路 Equivalent Circuit



绝对最大额定值 ABSOLUTE RATINGS (Tc=25℃)

项目 Parameter	符号 Symbol	数值 Value		单位 Unit
		FHP/S/D80N07E	FHF80N07E	
最高漏极—源极直流电压 Drain-Source Voltage	VDS	68		V
连续漏极电流* Drain Current -continuous *	ID（Tc=25℃）	80		A
	ID（Tc=100℃）	53		A
最大脉冲漏极电流（注 1） Drain Current – pulse（note 1）	IDM	320		A
最高栅源电压 Gate-Source Voltage	VGS	±20		V
单脉冲雪崩能量（注 2） Single Pulsed Avalanche Energy（note 2）	EAS	182		mJ
雪崩电流（注 1） Avalanche Current（note 1）	IAR	27		A
重复雪崩能量（注 1） Repetitive Avalanche Current（note 1）	EAR	68		mJ
二极管反向恢复最大电压变化速率（注 3） Peak Diode Recovery dv/dt（note 3）	dv/dt	5.0		V/ns
耗散功率 Power Dissipation	Pd（TC=25℃）	125	92	W
	-Derate above 25℃	1.0	0.73	W/℃
最高结温及存储温度 Operating and Storage Temperature Range	TJ, TSTG	-55~+150		℃
引线最高焊接温度 Maximum Lead Temperature for Soldering Purposes	TL	300		℃

*漏极电流由最高结温限制

*Drain current limited by maximum junction temperature

电特性 ELECTRICAL CHARACTERISTICS

项目 Parameter	符号 Symbol	测试条件 Tests conditions	最小 Min	典型 Typ	最大 Max	单位 Units
关态特性 Off –Characteristics						
漏－源击穿电压 Drain-Source Voltage	BV _{DSS}	I _D =250μA, V _{GS} =0V	68	-	-	V
击穿电压温度特性 Breakdown Voltage Temperature Coefficient	ΔBV _{DSS} /Δ T _J	I _D =250μA, referenced to 25℃	-	0.068	-	V/℃
零栅压下漏极漏电流 Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =68 V,V _{GS} =0V, T _C =25℃	-	-	1	μA
		V _{DS} =48V, T _C =125℃	-	-	100	μA
栅极体漏电流 Gate-body leakage current	I _{GSS} (F/R)	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
通态特性 On-Characteristics						
阈值电压 Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =250μA	2	-	4	V
静态导通电阻 Static Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =10V , I _D =40A	-	7.1	8.5	mΩ
正向跨导 Forward Transconductance	g _{fs}	V _{DS} = 5V, I _D =20A (note 4)	-	20	-	S
动态特性 Dynamic Characteristics						
输入电容 Input capacitance	C _{iss}	V _{DS} =30V, V _{GS} =0V, f=1.0MHz	-	3600	-	pF
输出电容 Output capacitance	C _{oss}		-	440	-	
反向传输电容 Reverse transfer capacitance	C _{rss}		-	180	-	
开关特性 Switching Characteristics						
延迟时间 Turn-On delay time	t _{d(on)}	V _{DD} =30V, I _D =40A, R _G =6Ω V _{GS} =10V (note 4, 5)	-	16	-	ns
上升时间 Turn-On rise time	t _r		-	95	-	ns
延迟时间 Turn-Off delay time	t _{d(off)}		-	47	-	ns
下降时间 Turn-Off Fall time	t _f		-	31	-	ns
栅极电荷总量 Total Gate Charge	Q _g	V _{DS} =30V , I _D =20A, V _{GS} =10V (note 4, 5)	-	40	-	nC
栅－源电荷 Gate-Source charge	Q _{gs}		-	11	-	nC
栅－漏电荷 Gate-Drain charge	Q _{gd}		-	15	-	nC
漏－源二极管特性及最大额定值 Drain-Source Diode Characteristics and Maximum Ratings						
正向最大连续电流 Maximum Continuous Drain -Source Diode Forward Current	I _S		-	-	80	A
正向最大脉冲电流 Maximum Pulsed Drain-Source Diode Forward Current	I _{SM}		-	-	320	A
正向压降 Drain-Source Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _S =80A	-	-	1.2	V
反向恢复时间 Reverse recovery time	t _{rr}	V _{GS} =0V, I _S =30A ,dI _F /dt=100A/μs (note 4)	-	21	-	ns
反向恢复电荷 Reverse recovery charge	Q _{rr}		-	17	-	nC

热特性 THERMAL CHARACTERISTIC

项目 Parameter	符号 Symbol	FHP/S/D80N07E	FHF80N07E	单位 Unit
结到管壳的热阻 Thermal Resistance, Junction to Case	Rth(j-c)	1.0	1.35	℃/W
结到环境的热阻 Thermal Resistance, Junction to Ambient	Rth(j-A)	62.5	60	℃/W

- 注释:
- 1: 脉冲宽度由最高结温限制
 - 2: L=0.5 mH, IAS=27A, VDD=48V, RG=25 Ω,起始结温 TJ=25℃
 - 3: ISD ≤80A,di/dt ≤300A/μs,VDD≤BVDSS,起始结温 TJ=25℃
 - 4: 脉冲测试: 脉冲宽度 ≤300μs,占空比≤2%
 - 5: 基本与工作温度无关

- Notes:
- 1: Pulse width limited by maximum junction temperature
 - 2: L=0.5mH, IAS=27 A, VDD=48V, RG=25 Ω,Starting TJ=25℃
 - 3: ISD ≤80A,di/dt ≤300A/μs,VDD≤BVDSS, Starting TJ=25℃
 - 4: Pulse Test: Pulse Width ≤300μs,Duty Cycle≤2%
 - 5: Essentially independent of operating temperature

Typical Performance Characteristics

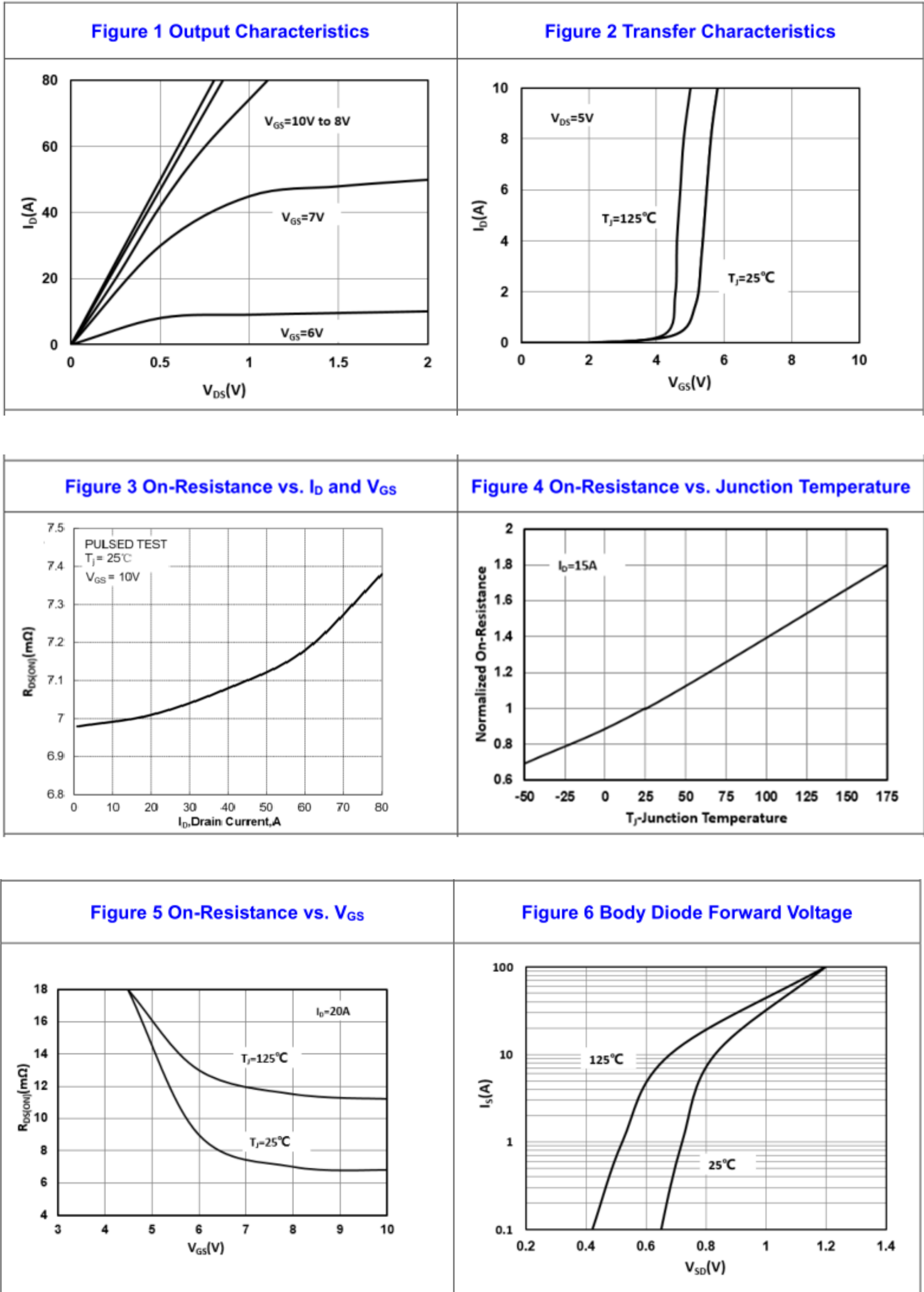


Figure 7 Gate-Charge Characteristics

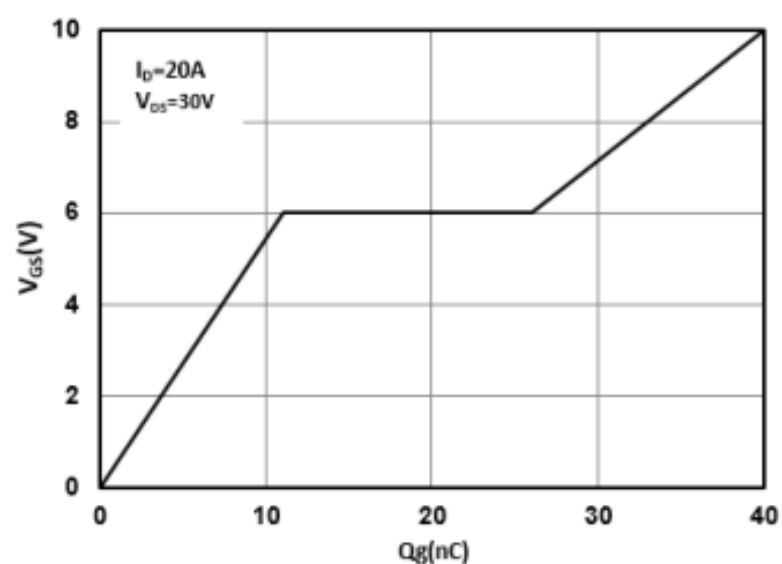


Figure 8 Capacitance Characteristics

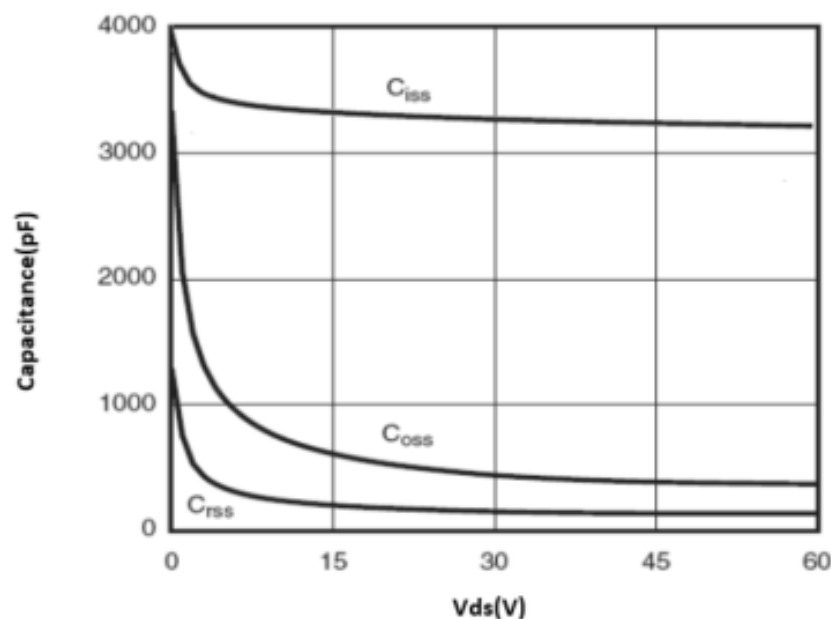


Figure 9 Maximum Forward Biased Safe Operation Area

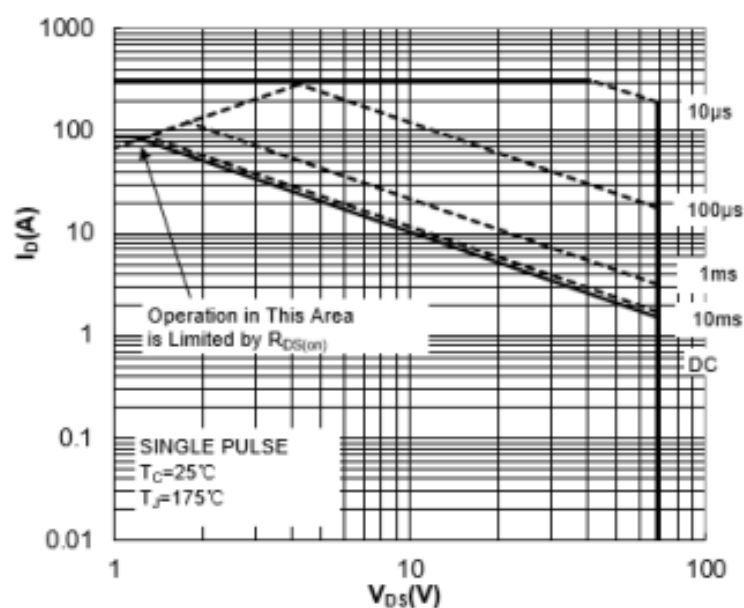


Figure 10 Single Pulse Power Rating Junction-to-Ambient

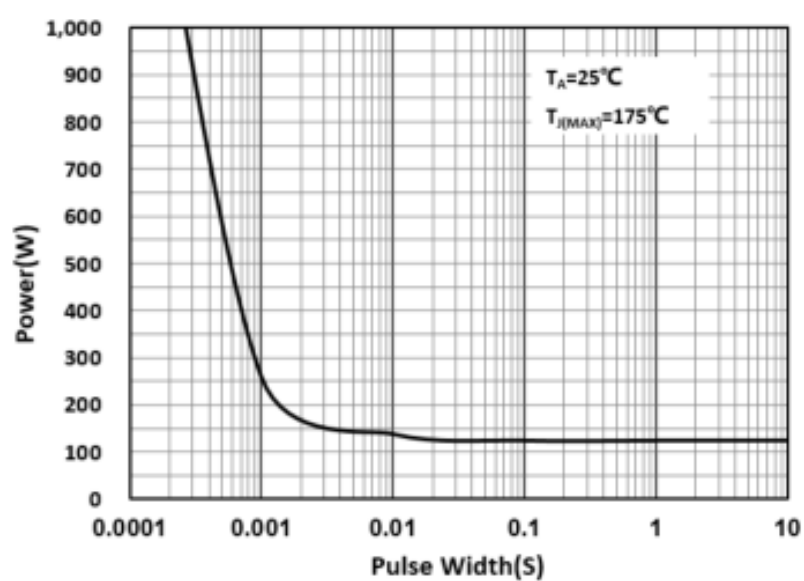
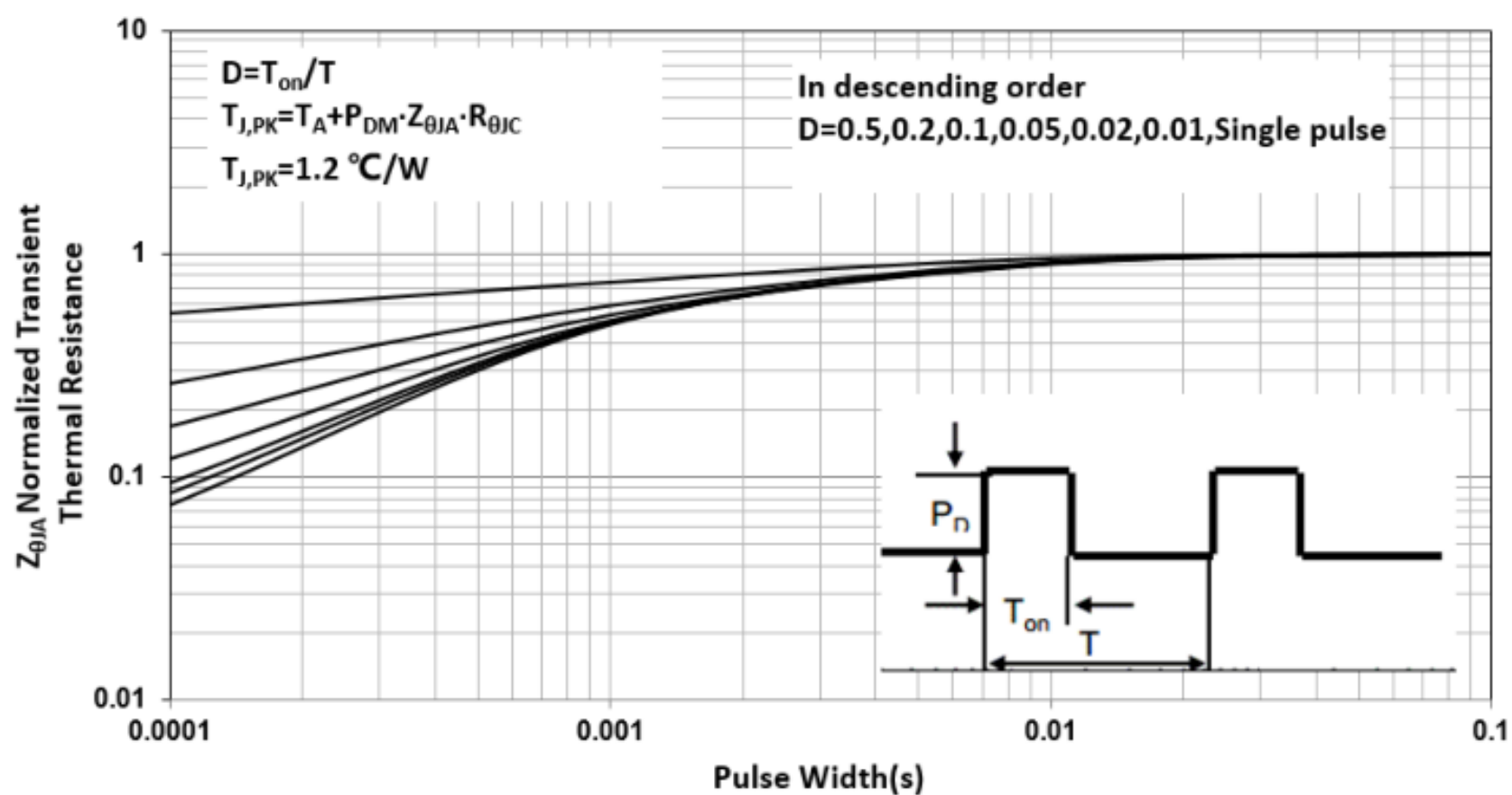
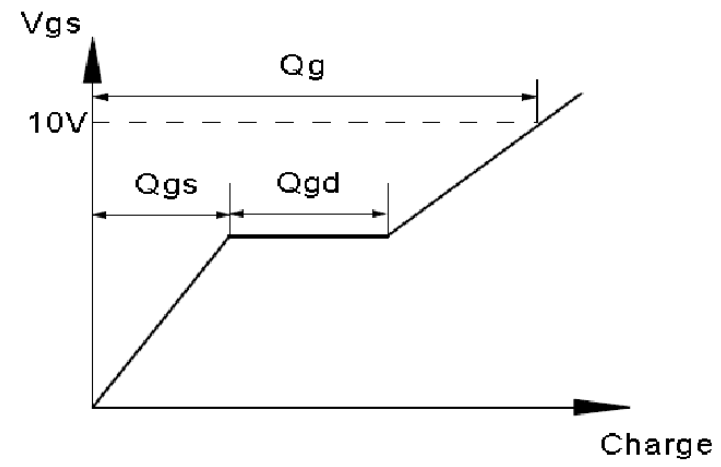
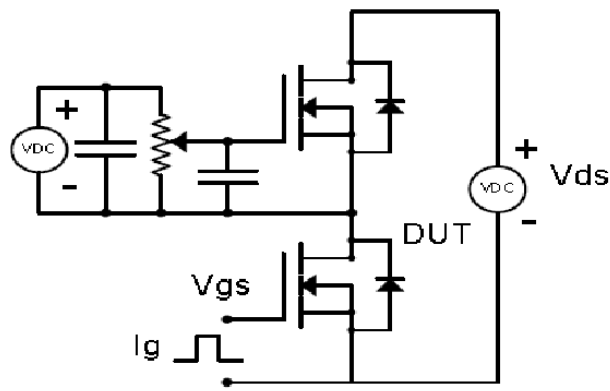


Figure 11 Normalized Maximum Transient Thermal Impedance



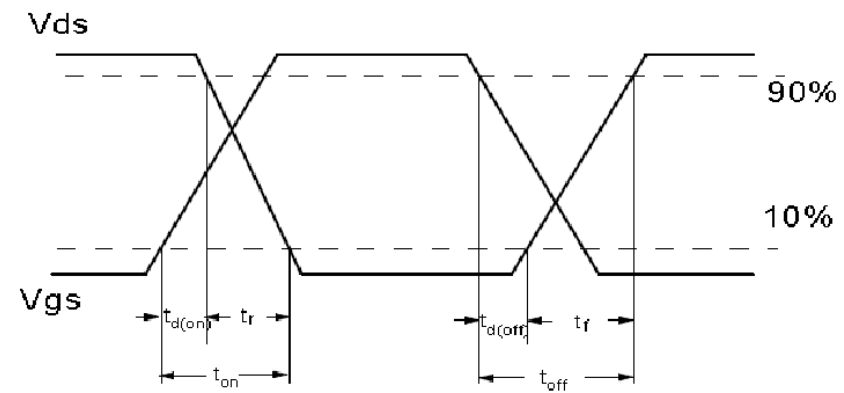
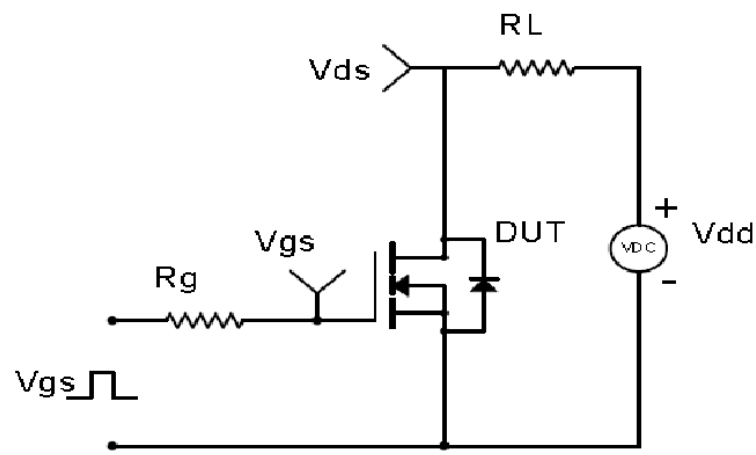
Test Circuit & Waveform

Gate Charge Test Circuit & Waveform

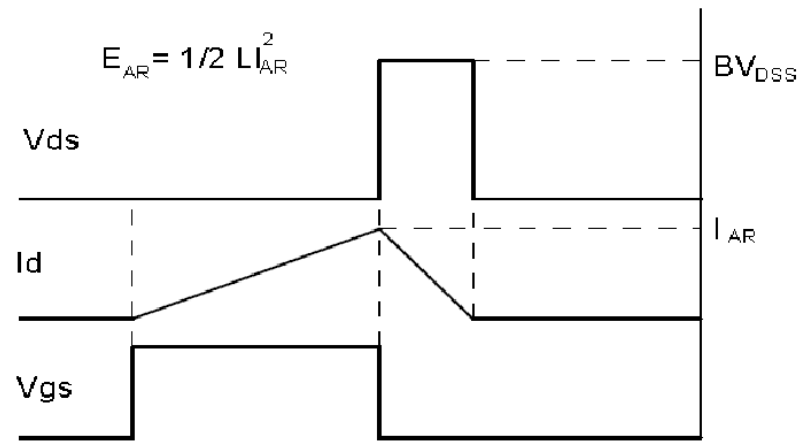
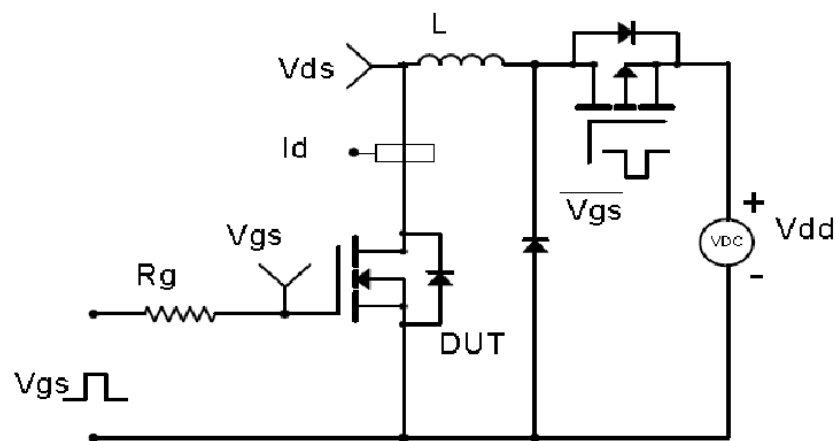


Resistive Switching Test Circuit & Waveforms

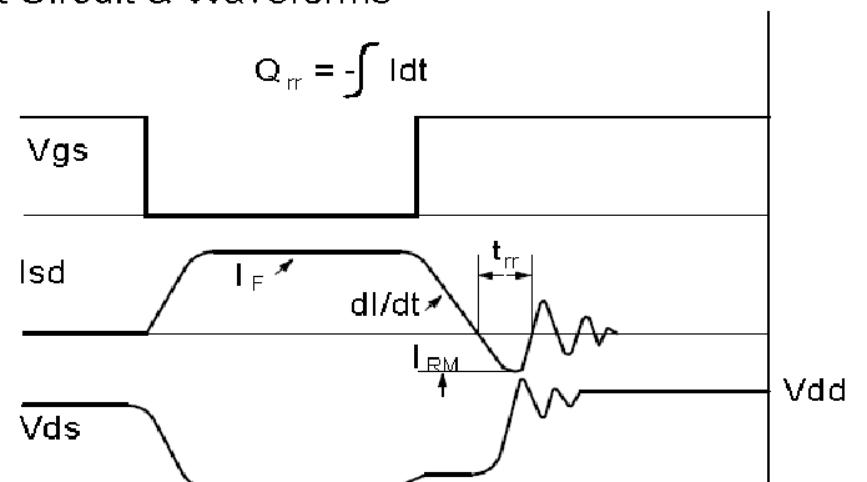
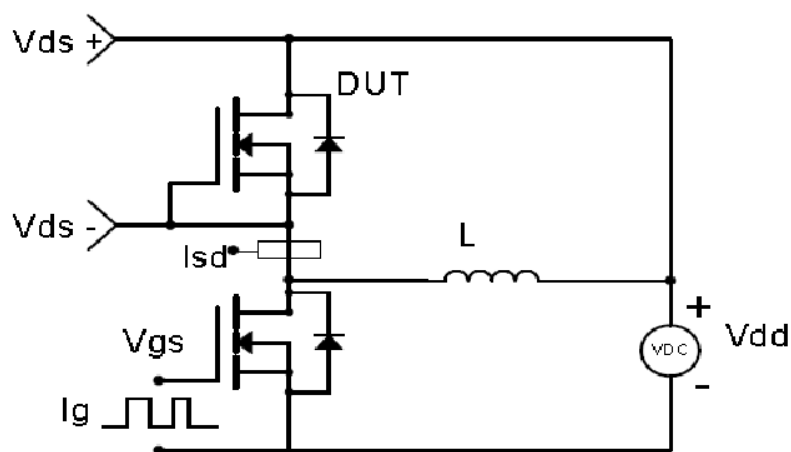
Resistive Switching Test Circuit & Waveforms



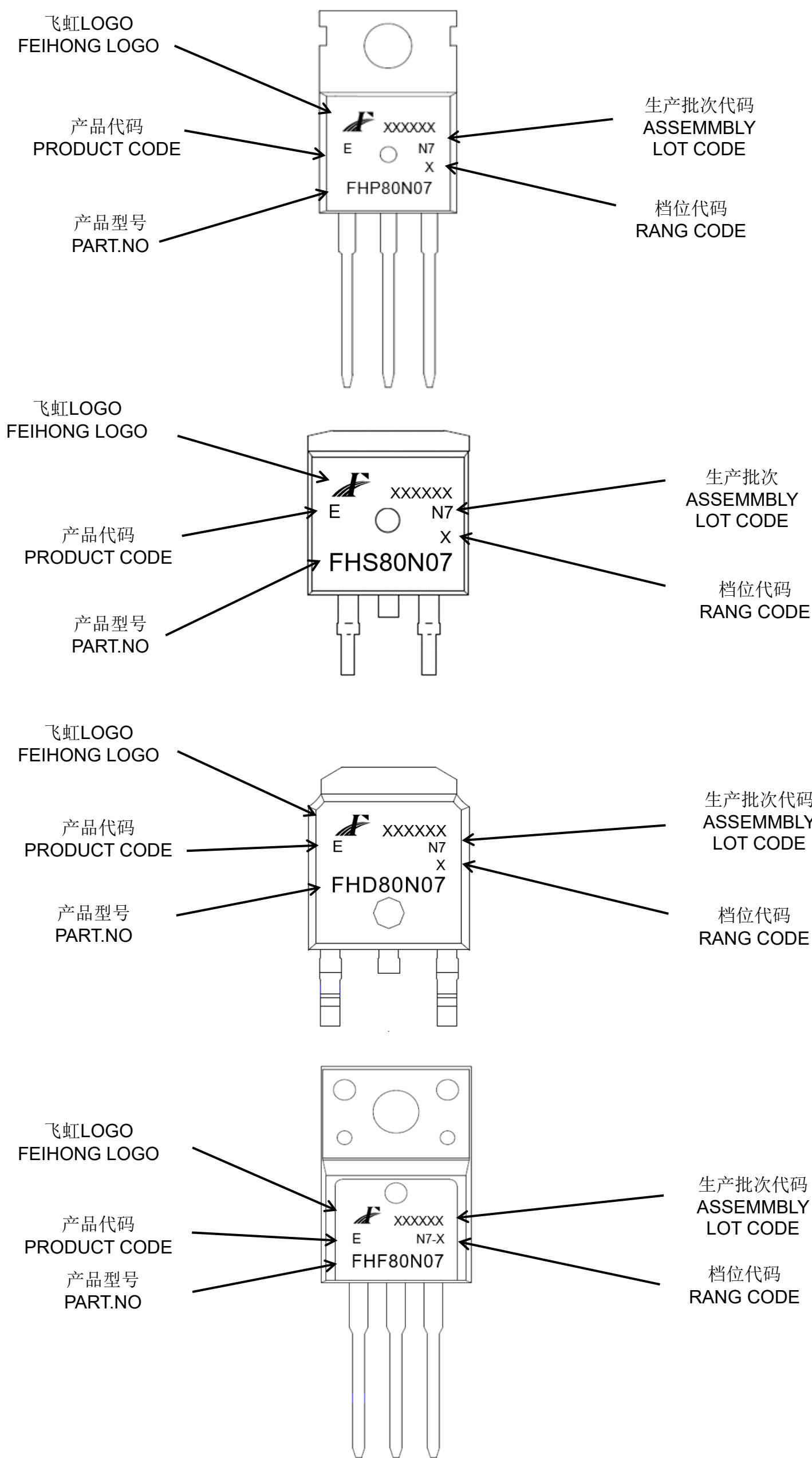
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



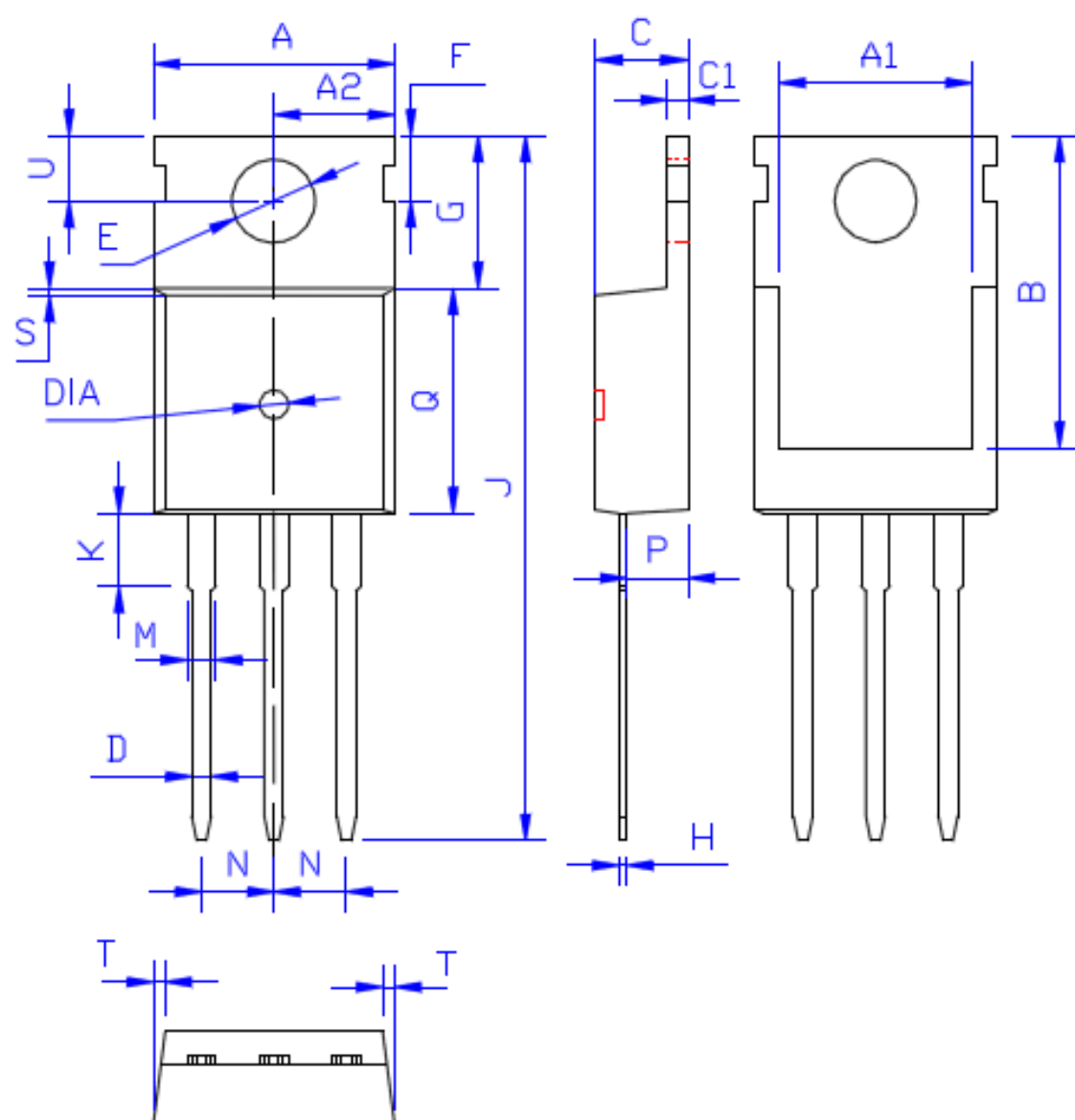
印记 Marking:



外形尺寸:

Package Dimension:

TO-220



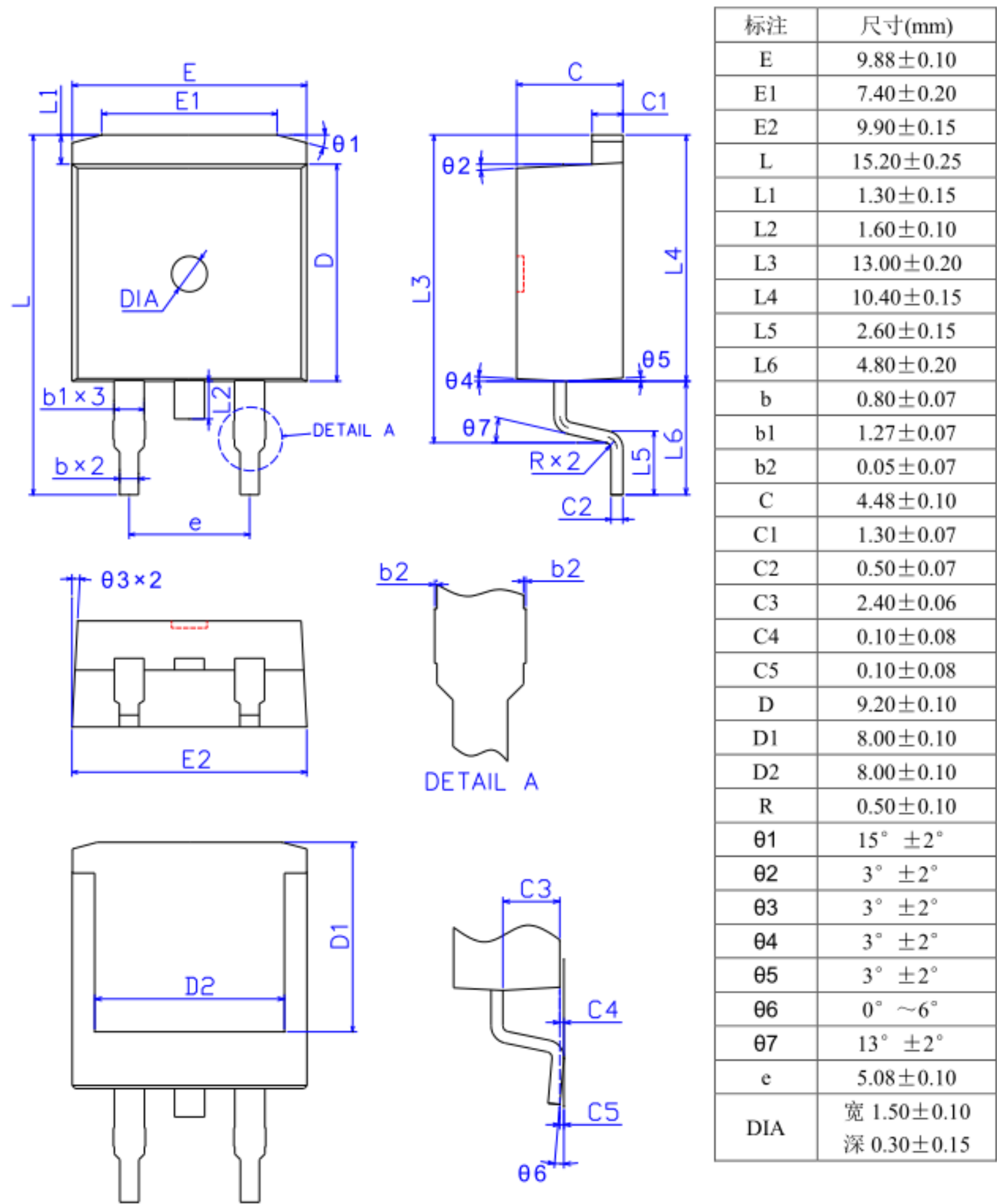
DIM	MILLIMETERS
A	10.00 ± 0.30
A1	8.00 ± 0.30
A2	5.00 ± 0.30
B	13.20 ± 0.40
C	4.50 ± 0.20
C1	1.30 ± 0.20
D	0.80 ± 0.20
E	3.60 ± 0.20
F	3.00 ± 0.30
G	6.60 ± 0.40
H	0.50 ± 0.20
J	28.88 ± 0.50
K	3.00 ± 0.30
M	1.30 ± 0.30
N	Typical 2.54
P	2.40 ± 0.40
Q	9.20 ± 0.40
S	0.25 ± 0.15
T	0.25 ± 0.15
U	2.80 ± 0.30
DIA	宽 1.50 ± 0.10 深 0.50 MAX

(Unit: mm)

外形尺寸:

Package Dimension:

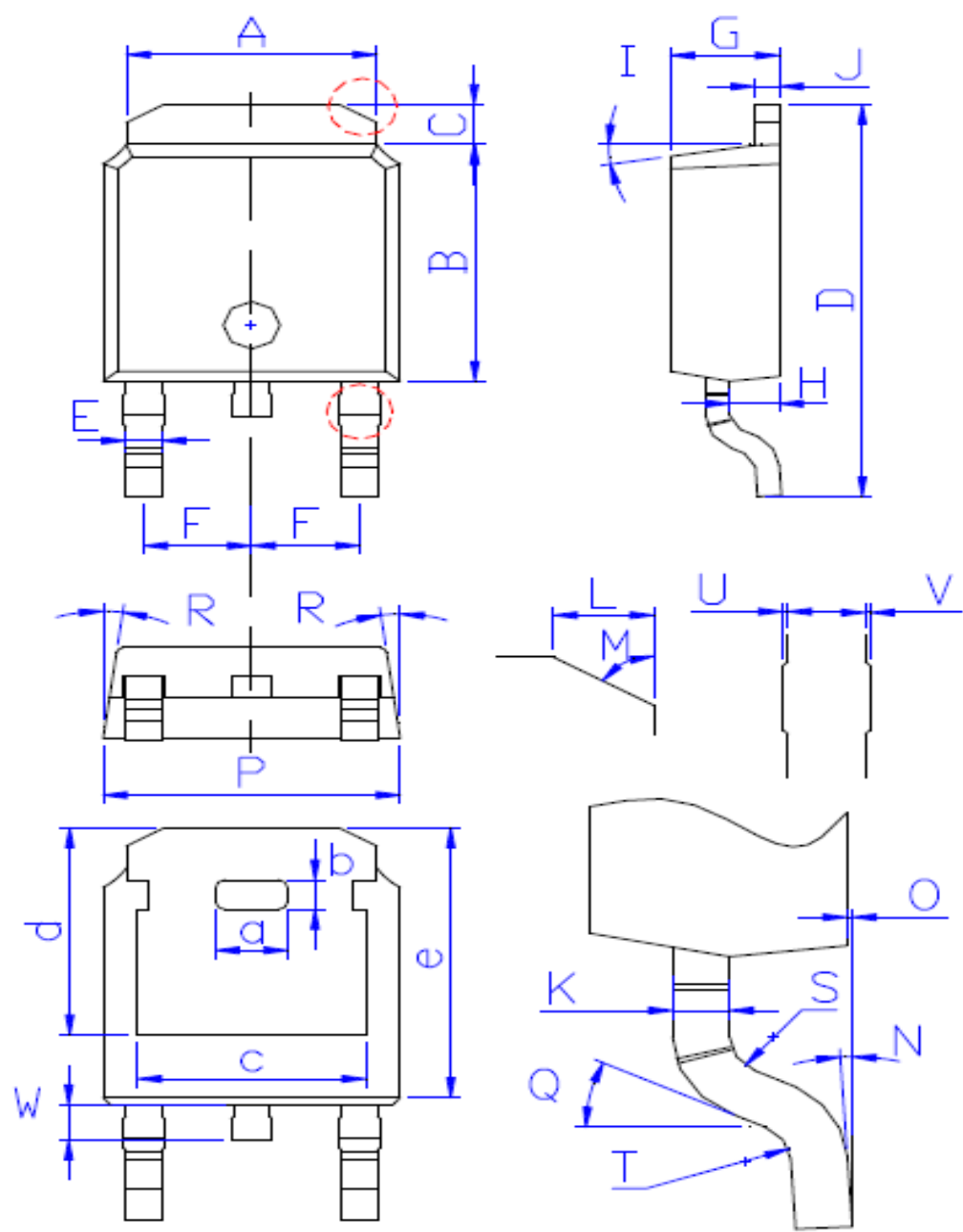
TO-263



外形尺寸:

Package Dimension:

TO-252



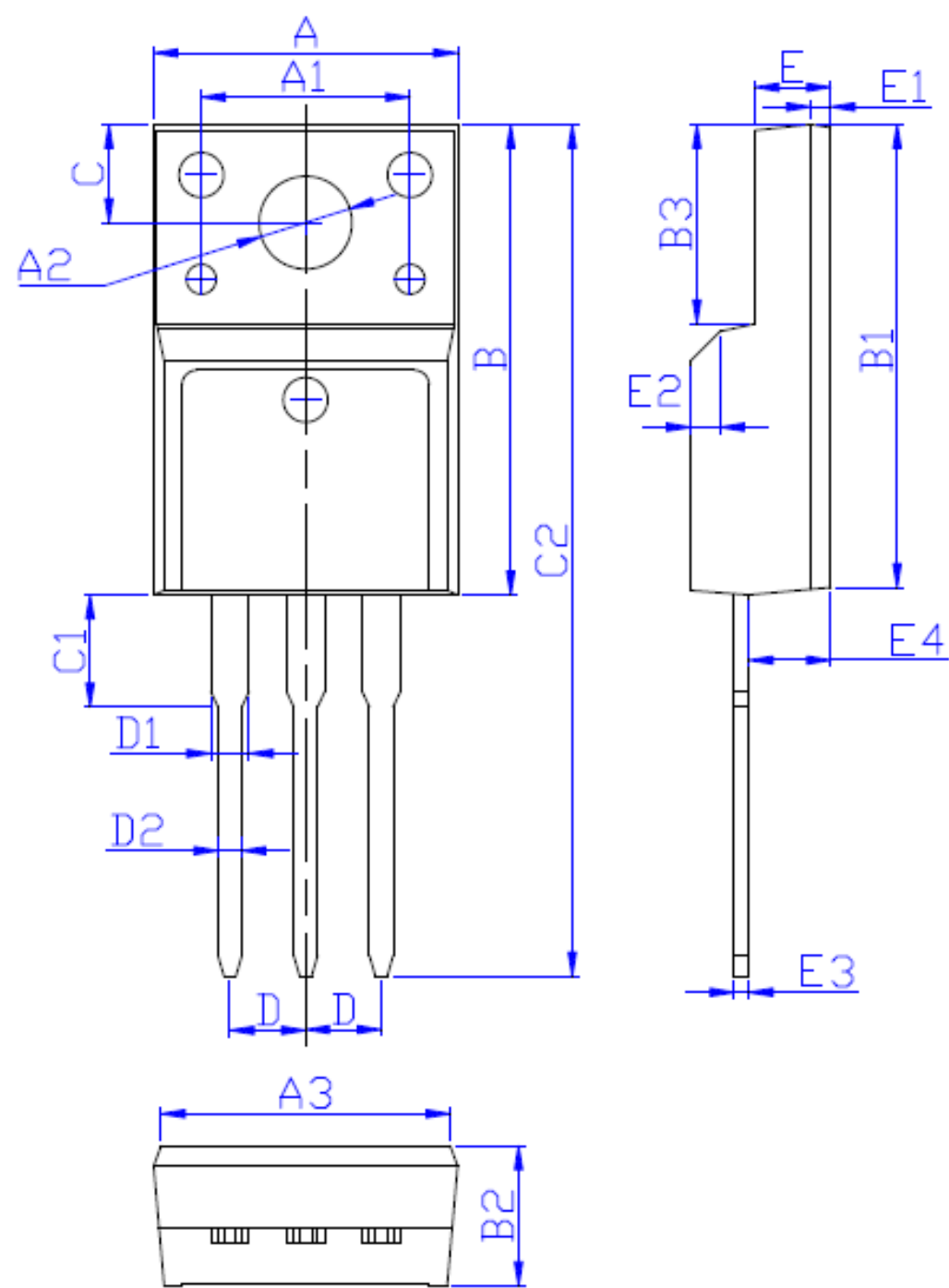
DIM	MILLIMETERS
A	5.34±0.30
B	6.00±0.30
C	1.05±0.30
D	9.95±0.30
E	0.76±0.15
F	2.28±0.15
G	2.30±0.30
H	1.06±0.30
I	(4-10)°
J	0.51±0.15
K	0.52±0.15
L	0.80±0.30
M	60°
N	(0-10)°
O	0.05±0.05
P	6.60±0.30
Q	25°
R	(4-8.5)°
S	R0.40
T	R0.40
U	0.05±0.05
V	0.05±0.05
W	0.90±0.30
a	1.80±0.30
b	0.75±0.30
c	4.85±0.30
d	5.30±0.30
e	6.90±0.30

(Units: mm)

外形尺寸:

Package Dimension:

TO-220F



DIM	MILLIMETERS
A	10.16±0.30
A1	7.00±0.20
A2	3.12±0.20
A3	9.70±0.30
B	15.90±0.50
B1	15.60±0.50
B2	4.70±0.30
B3	6.70±0.30
C	3.30±0.25
C1	3.25±0.30
C2	28.70±0.50
D	Typical 2.54
D1	1.47 (MAX)
D2	0.80±0.20
E	2.55±0.25
E1	0.70±0.25
E2	1.0×45°
E3	0.50±0.20
E4	2.75±0.30

(Unit:mm)